

Notice of References Cited

Application/Control No.

09/695,981

Examiner

Lin Ye

Diplicant(s)/Patent Under
Reexamination
ITO ET AL.

Art Unit
2612

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,035,323	03-2000	Narayen et al.	709/201
	В	US-2001/0012060	08-2001	Wakui, Yoshio	348/211
	С	US-6,335,742 🗸	01-2002	Takemoto, Hiroshi	345/781
	D	US-6,405,201	06-2002	Nazari, Siamak	707/8
	E	US-6,233,015	05-2001	Miller et al.	348/333.05
	F	US-6,370,580	04-2002	Kriegsman, Mark E.	709/226
	G	US-6,556,243 (04-2003	Dotsubo et al.	348/231.2
	Н	US-6,307,550 -	10-2001	Chen et al.	345/418
	ı	US-6,278,447 <	08-2001	Anderson, Eric C.	345/723
	J	US-6,201,571 /	03-2001	Ota, Takayuki	348/239
	Κ	US-6,204,877 /	03-2001	Kiyokawa, Izuru	348/211.3
	L	US-6,567,121 /	05-2003	Kuno, Tomoko	348/211.3
	М	US-5,917,542	06-1999	Moghadam et al.	348/231.99

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11191870 A	07-1999	Japan	TANAKA, HIROSHI	H04N 05/76
	0					
	Ρ					
	σ			_		
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U,	
	v	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.